

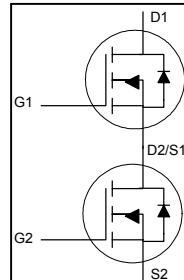


## ▼ Simple Drive Requirement

## ▼ Easy for DC/DC Buck

## Converter Application

## ▼ RoHS Compliant &amp; Halogen-Free

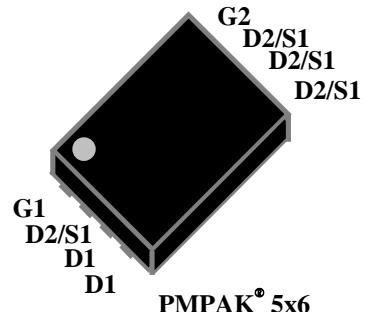
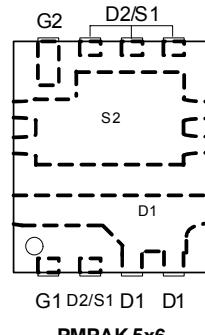


CH-1	$BV_{DSS}$	30V
	$R_{DS(ON)}$	8.2mΩ
CH-2	$BV_{DSS}$	30V
	$R_{DS(ON)}$	2.4mΩ

**Description**

Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The control MOSFET (CH-1) and synchronous MOSFET (CH-2) co-package for synchronous buck converters. The package provide optimal efficiency with low stray inductance and very low on-resistance.

**Absolute Maximum Ratings@ $T_j=25^\circ\text{C}$ (unless otherwise specified)**

Symbol	Parameter	Rating		Units
		CH-1	CH-2	
$V_{DS}$	Drain-Source Voltage	30	30	V
$V_{GS}$	Gate-Source Voltage	+20 / -12	+20 / -12	V
$I_D @ T_C = 25^\circ\text{C}$	Drain Current (Silicon Limited)	42	100	A
$I_D @ T_A = 25^\circ\text{C}$	Drain Current <sup>3</sup> , $V_{GS} @ 10\text{V}$	12.2	24.3	A
$I_D @ T_A = 70^\circ\text{C}$	Drain Current <sup>3</sup> , $V_{GS} @ 10\text{V}$	9.8	19.4	A
$I_{DM}$	Pulsed Drain Current <sup>1</sup>	40	75	A
$P_D @ T_A = 25^\circ\text{C}$	Total Power Dissipation <sup>3</sup>	2.08	2.27	W
$T_{STG}$	Storage Temperature Range	-55 to 150		°C
$T_J$	Operating Junction Temperature Range	-55 to 150		°C

**Thermal Data**

Symbol	Parameter	Rating		Units
		CH-1	CH-2	
$R_{thj-c}$	Maximum Thermal Resistance, Junction-case	5	3	°C/W
$R_{thj-a}$	Maximum Thermal Resistance, Junction-ambient <sup>3</sup>	60	55	°C/W
$R_{thj-a}$	Maximum Thermal Resistance, Junction-ambient <sup>4</sup>	130	120	°C/W



# AP3D2R6CMT

## CH-1 Electrical Characteristics@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$	30	-	-	V
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance <sup>2</sup>	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=14\text{A}$	-	-	8.2	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=7\text{A}$	-	-	13	$\text{m}\Omega$
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$	1	-	2.5	V
$\text{g}_{\text{fs}}$	Forward Transconductance	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=14\text{A}$	-	33	-	S
$\text{I}_{\text{DSS}}$	Drain-Source Leakage Current	$\text{V}_{\text{DS}}=24\text{V}, \text{V}_{\text{GS}}=0\text{V}$	-	-	10	$\text{uA}$
$\text{I}_{\text{GSS}}$	Gate-Source Leakage	$\text{V}_{\text{GS}}=+20\text{V}, \text{V}_{\text{DS}}=0\text{V}$	-	-	100	$\text{nA}$
$\text{Q}_{\text{g}}$	Total Gate Charge	$\text{I}_D=7\text{A}$	-	7	11.2	$\text{nC}$
$\text{Q}_{\text{gs}}$	Gate-Source Charge	$\text{V}_{\text{DS}}=15\text{V}$	-	4	-	$\text{nC}$
$\text{Q}_{\text{gd}}$	Gate-Drain ("Miller") Charge		-	1	-	$\text{nC}$
$t_{\text{d(on)}}$	Turn-on Delay Time	$\text{V}_{\text{DS}}=15\text{V}$	-	9	-	ns
$t_{\text{r}}$		$\text{I}_D=14\text{A}$	-	48	-	ns
$t_{\text{d(off)}}$	Turn-off Delay Time	$\text{R}_G=3\Omega$	-	17	-	ns
$t_{\text{f}}$	Fall Time	$\text{V}_{\text{GS}}=10\text{V}$	-	2	-	ns
$\text{C}_{\text{iss}}$	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V}$	-	1200	1920	$\text{pF}$
$\text{C}_{\text{oss}}$	Output Capacitance	$\text{V}_{\text{DS}}=15\text{V}$	-	270	-	$\text{pF}$
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance		-	10	-	$\text{pF}$
$\text{R}_{\text{g}}$	Gate Resistance	$f=1.0\text{MHz}$	-	1	2	$\Omega$

## Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
$\text{V}_{\text{SD}}$	Forward On Voltage <sup>2</sup>	$\text{I}_S=14\text{A}, \text{V}_{\text{GS}}=0\text{V}$	-	-	1.2	V
$t_{\text{rr}}$	Reverse Recovery Time	$\text{I}_S=14\text{A}, \text{V}_{\text{GS}}=0\text{V}$	-	17	-	ns
$\text{Q}_{\text{rr}}$	Reverse Recovery Charge		-	9	-	$\text{nC}$

**CH-2 Electrical Characteristics@T<sub>j</sub>=25°C(unless otherwise specified)**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	30	-	-	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =20A	-	-	2.4	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =12A	-	-	3	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	1.1	-	2.5	V
g <sub>f</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =20A	-	86	-	S
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V	-	-	10	uA
I <sub>GSS</sub>	Gate-Source Leakage	V <sub>GS</sub> =+20V, V <sub>DS</sub> =0V	-	-	100	nA
Q <sub>g</sub>	Total Gate Charge	I <sub>D</sub> =12A	-	30	48	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>DS</sub> =15V	-	11	-	nC
Q <sub>gd</sub>	Gate-Drain ("Miller") Charge	V <sub>GS</sub> =4.5V	-	6.5	-	nC
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DS</sub> =15V	-	11	-	ns
t <sub>r</sub>	Rise Time	I <sub>D</sub> =20A	-	64	-	ns
t <sub>d(off)</sub>	Turn-off Delay Time	R <sub>G</sub> =3Ω	-	50	-	ns
t <sub>f</sub>	Fall Time	V <sub>GS</sub> =10V	-	14	-	ns
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V	-	4300	6880	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =15V	-	1050	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f=1.0MHz	-	34	-	pF
R <sub>g</sub>	Gate Resistance	f=1.0MHz	-	1.7	3.4	Ω

**Source-Drain Diode**

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V <sub>SD</sub>	Forward On Voltage <sup>2</sup>	I <sub>S</sub> =20A, V <sub>GS</sub> =0V	-	-	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> =20A, V <sub>GS</sub> =0V	-	35	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	di/dt=100A/μs	-	29	-	nC

**Notes:**

- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse test
- 3.Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board, on steady-state
- 4.Surface mounted on Min. copper pad of FR4 board, on steady-state

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

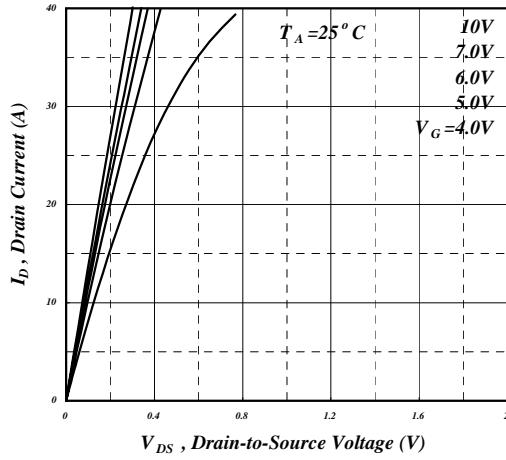
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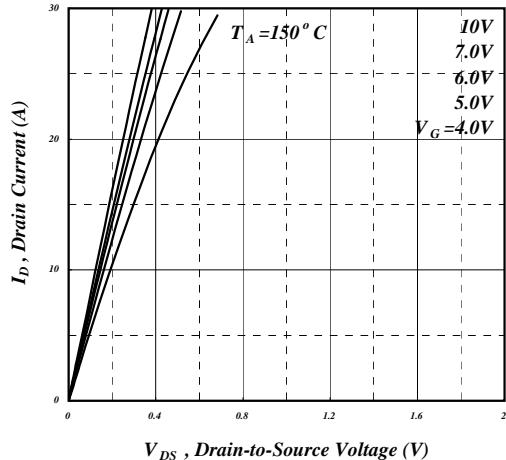


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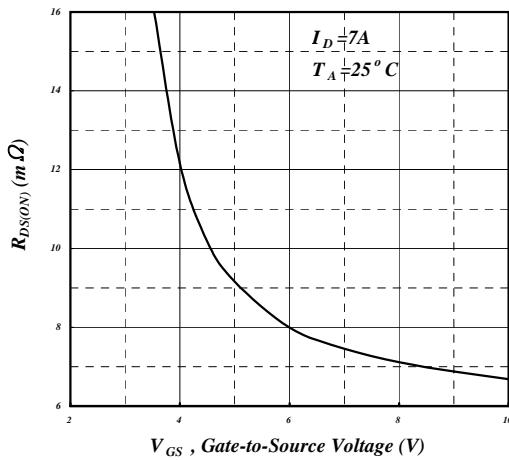
## Channel-1



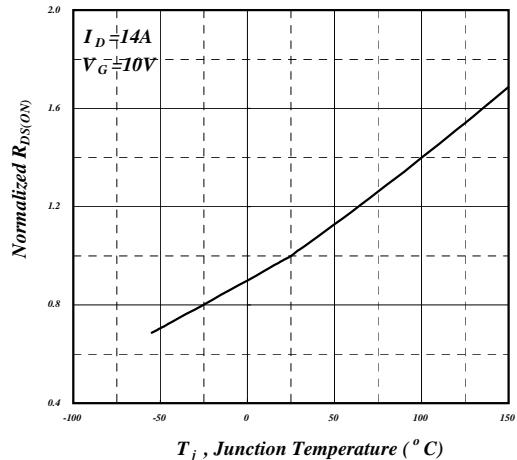
**Fig 1. Typical Output Characteristics**



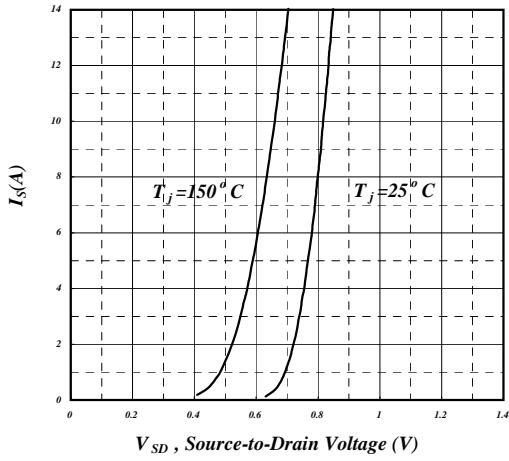
**Fig 2. Typical Output Characteristics**



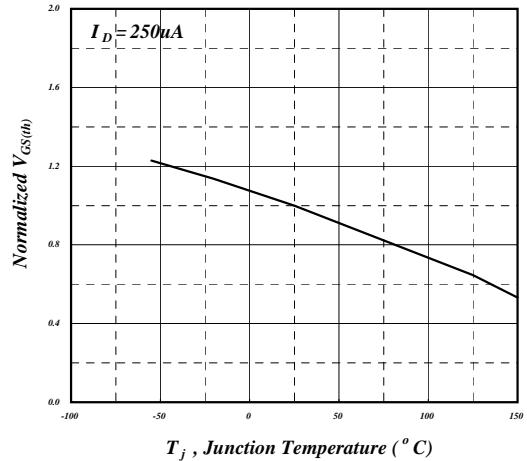
**Fig 3. On-Resistance v.s. Gate Voltage**



**Fig 4. Normalized On-Resistance v.s. Junction Temperature**



**Fig 5. Forward Characteristic of Reverse Diode**



**Fig 6. Gate Threshold Voltage v.s. Junction Temperature**



## Channel-1

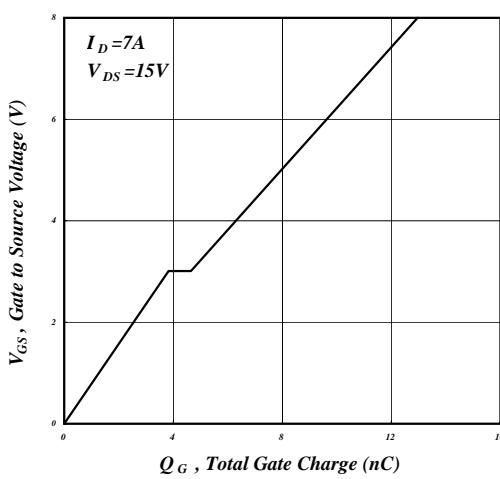


Fig 7. Gate Charge Characteristics

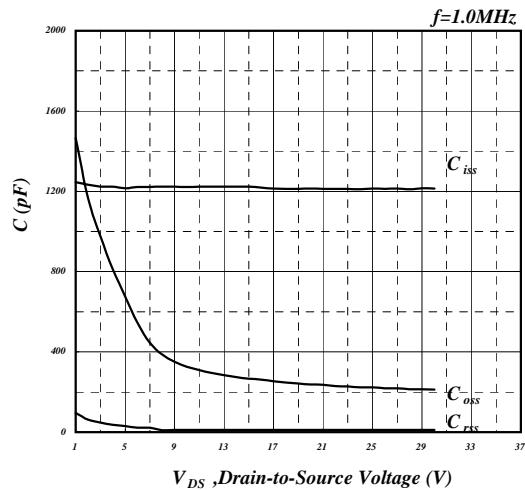


Fig 8. Typical Capacitance Characteristics

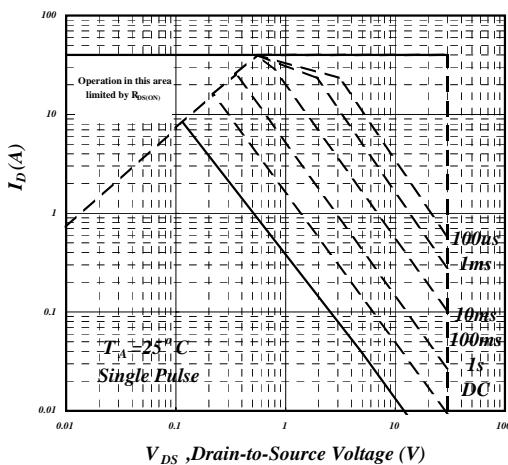


Fig 9. Maximum Safe Operating Area

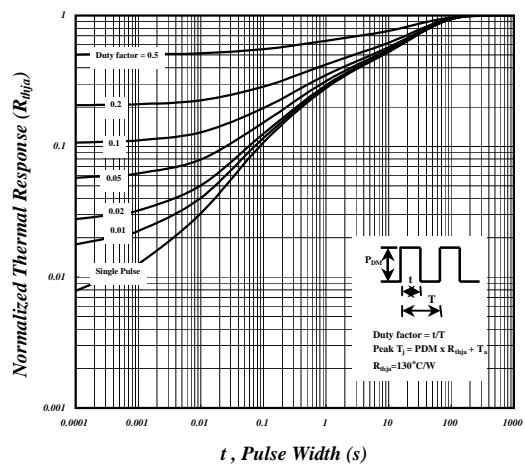


Fig 10. Effective Transient Thermal Impedance

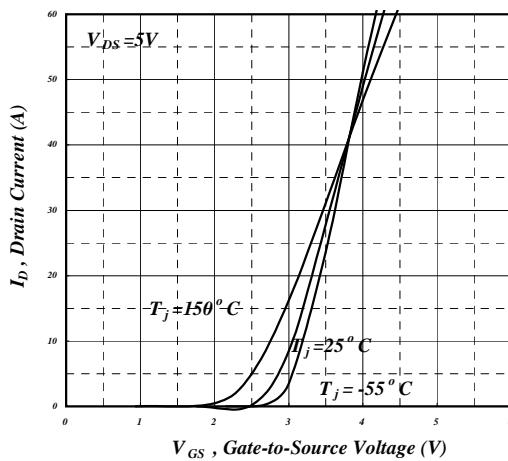


Fig 11. Transfer Characteristics

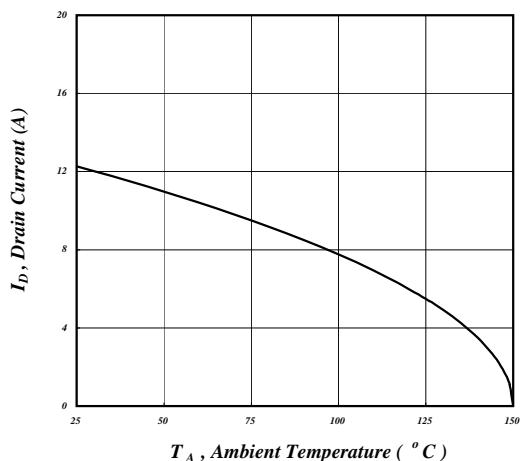
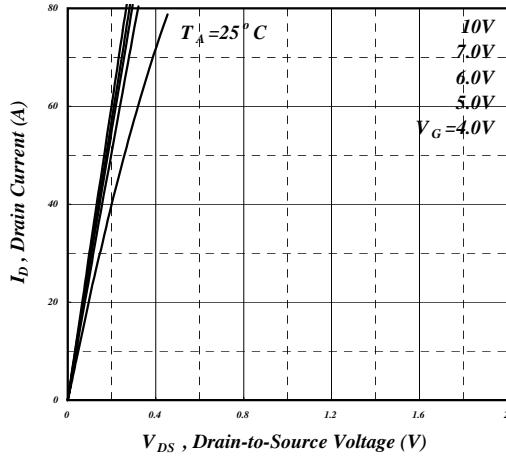


Fig 12. Drain Current v.s. Ambient Temperature

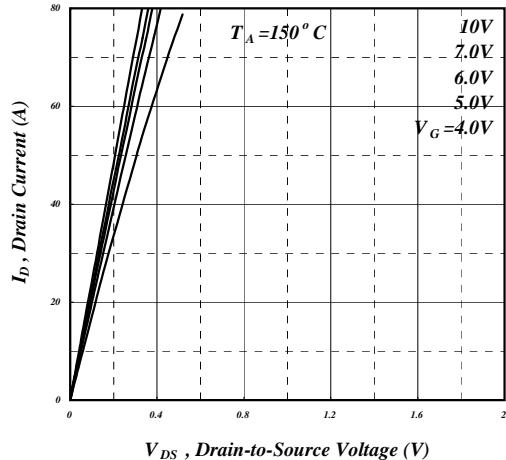


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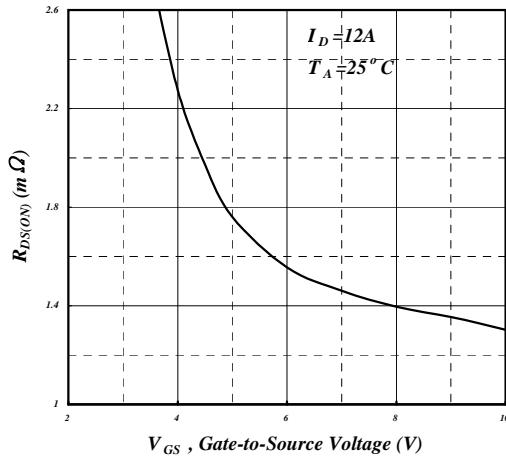
## Channel-2



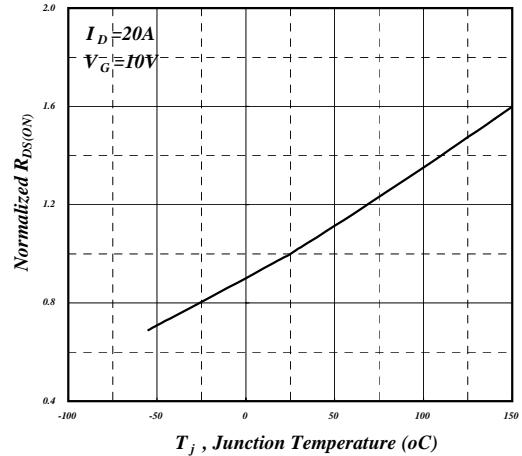
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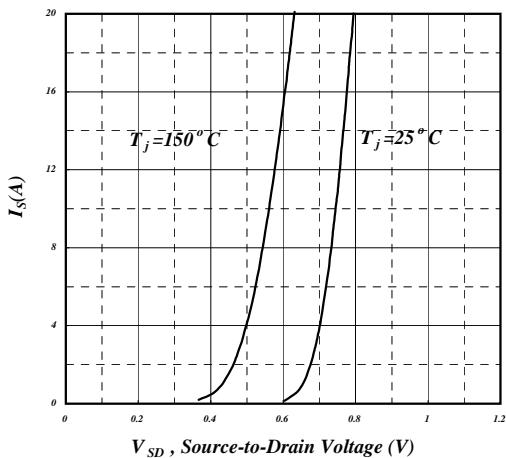
**Fig 2. Typical Output Characteristics**



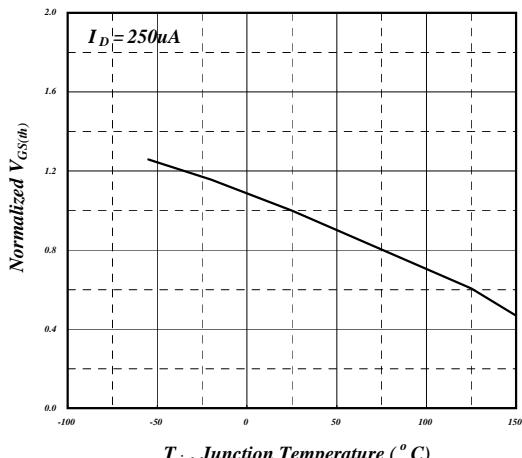
**Fig 3. On-Resistance v.s. Gate Voltage**



**Fig 4. Normalized On-Resistance v.s. Junction Temperature**



**Fig 5. Forward Characteristic of Reverse Diode**



**Fig 6. Gate Threshold Voltage v.s. Junction Temperature**



## Channel-2

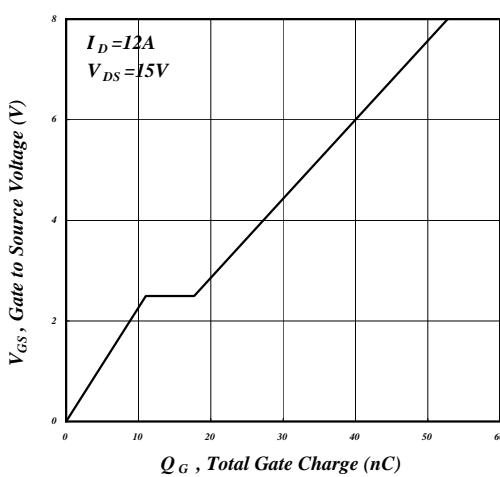


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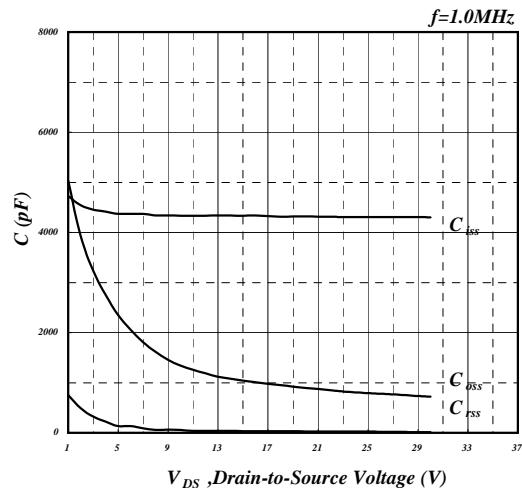


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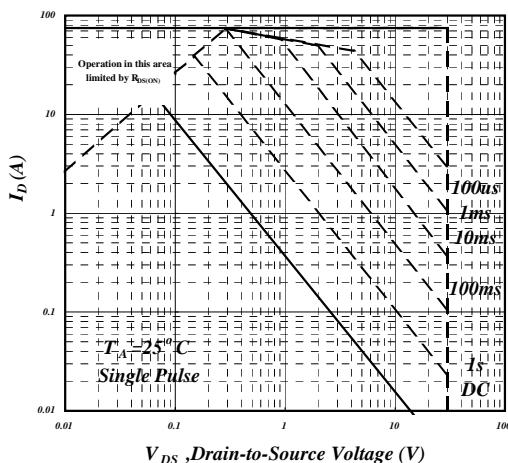


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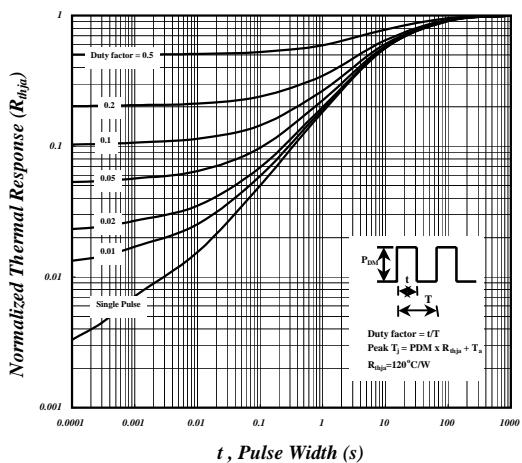


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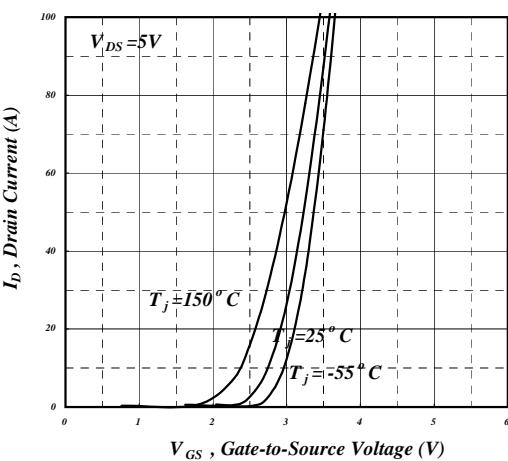


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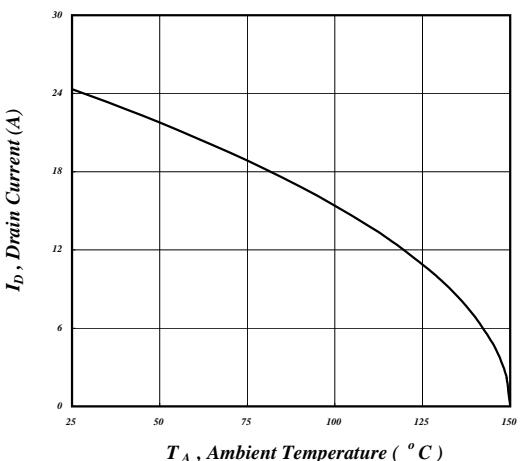


Fig 12. Drain Current v.s. Ambient Temperature



**AP3D2R6CMT**

## **MARKING INFORMATION**

